

Docket No.: P2001,0097

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

J1000 U.S. PRO
J1000 U.S. PRO
02/13/02
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Applicant : DETLEV RICHTER
Filed : CONCURRENTLY HEREWITH
Title : SEMICONDUCTOR MODULE WITH A CONFIGURATION FOR THE SELF-TEST OF A PLURALITY OF INTERFACE CIRCUITS AND TEST METHOD

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner of Patents and Trademarks,
Washington, D.C. 20231

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

German Published Non-Prosecuted Patent Application DE 198 32 307 A1 (Schaffroth et al.), dated February 3, 2000, integrated circuit with self-testing device;

German Patent Application DE 199 01 460 C1 (Daehn), dated August 31, 2000, integrated circuit and procedure for functional testing of bond pad cells;

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,



For Applicant

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Date: February 13, 2002

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Attorney Docket No.: P2001,0097 Appl. No.			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Applicant DETLEV RICHTER			
				Filing Date February 13, 2002 Group Art Unit			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	198 32 307 A1	2/3/00	Germany			
	K	199 01 460 C1	8/31/00	Germany			
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							